

**Search Notes**

Application/Control No.

10/644,794

Examiner

Emily Y. Chan

Applicant(s)/Patent under  
Reexamination

NOJIRI ET AL.

Art Unit

2829

**SEARCHED**

Class	Subclass	Date	Examiner
324	770	5/9/2005	EC
324	770	8/4/2005	EC
above	updated	8/4/2005	EC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PG PUB	searchd	8/4/2005	EC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventorship and EAST for all databases searched.	5/9/2005	EC
Consulted with primary examiner Vinh P Nguyen.	5/9/2005	EC